

PN4091 PN4092 PN4093 MMBF4091 MMBF4092 **MMBF4093**





NOTE: Source & Drain are interchangeable

N-Channel Switch

This device is designed for low level analog switching, sample and hold circuits and chopper stabalized amplifiers. Sourced from Process 51. See J111 for characteristics.

Absolute Maximum Ratings*

TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units	
V_{DG}	Drain-Gate Voltage	40	V	
V_{GS}	Gate-Source Voltage	- 40	V	
I _{GF}	Forward Gate Current	50	mA	
T _J ,T _{stg}	Operating and Storage Junction Temperature Range	-55 to +150	°C	

^{*}These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

1) These ratings are based on a maximum junction temperature of 150 degrees C.
2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations

Thermal Characteristics TA = 25°C unless otherwise noted

Symbol	Characteristic	Max		Units
		PN4091-4093	*MMBF4091-4093	
P _D	Total Device Dissipation	625	350	mW
	Derate above 25°C	5.0	2.8	mW/°C
$R_{\theta JC}$	Thermal Resistance, Junction to Case	125		°C/W
R _{θJA}	Thermal Resistance, Junction to Ambient	357	556	°C/W

^{*}Device mounted on FR-4 PCB 1.6" X 1.6" X 0.06."

N-Channel Switch

(continued)

Symbol	Parameter	Test Conditions	5	Min	Max	Units
OFF CHAF	RACTERISTICS					
V _{(BR)GSS}	Gate-Source Breakdown Voltage	$I_G = 1.0 \mu A, V_{DS} = 0$		- 40		V
V _{GS(off)}	Gate-Source Cutoff Voltage	$V_{DS} = 20 \text{ V}, I_{D} = 1.0 \text{ nA}$	4091 4092	- 5.0 - 2.0	- 10 - 7.0	V
			4093	- 1.0	- 5.0	V
I _{DGO}	Drain-Gate Leakage Current	$V_{DG} = 20 \text{ V}, I_{S} = 0$ $V_{DG} = 20 \text{ V}, I_{S} = 0, T_{A} = 150$	0°C		- 200 - 400	pA nA
$I_{D(off)}$	Drain Cutoff Leakage Current	$V_{DS} = 20 \text{ V}, V_{GS} = -12 \text{ V}$	4091		200	pА
		$V_{DS} = 20 \text{ V}, V_{GS} = -8.0 \text{ V}$ $V_{DS} = 20 \text{ V}, V_{GS} = -6.0 \text{ V}$	4092 4093		200 200	pA pA
		$V_{DS} = 20 \text{ V}, V_{GS} = -12 \text{ V},$ $T_A = 150^{\circ}\text{C}$ $V_{DS} = 20 \text{ V}, V_{GS} = -8.0 \text{ V},$	4091		400	nA
		$V_{DS} = 20 \text{ V}, V_{GS} = -8.0 \text{ V},$ $T_A = 150^{\circ}\text{C}$ $V_{DS} = 20 \text{ V}, V_{GS} = -6.0 \text{ V},$	4092		400	nA
		$T_A = 150^{\circ}C$	4093		400	nA
V _{DS(on)}	Drain-Source On Voltage Drain-Source On Resistance	$I_D = 6.6 \text{ mA}, V_{GS} = 0$ $I_D = 4.0 \text{ mA}, V_{GS} = 0$ $I_D = 2.5 \text{ mA}, V_{GS} = 0$ $I_D = 1.0 \text{ mA}, V_{GS} = 0$	4093 4091 4092 4093 4091 4092	8.0	0.2 0.2 0.2 30 50	mA V V V Ω
S-11VWS	 GNAL CHARACTERISTICS		4093		80	Ω
r _{ds(on)}	Drain-Source On Resistance	$V_{DS} = V_{GS} = 0$, f= 1.0 kHz	4091		30	Ω
rus(on)		150 100 5,1 110 11.12	4092 4093		50 80	Ω
C _{iss}	Input Capacitance	$V_{DS} = 20, V_{GS} = 0, f = 1.0 \text{ N}$	ЛHz		16	pF
C _{rss}	Reverse Transfer Capacitance	V _{GS} = - 20 V, f = 1.0 MHz			5.0	pF
SWITCHI	NG CHARACTERISTICS					
t _{on}	Turn-On Time	I _{D(on)} = 12 mA	4091		25	ns
		$I_{D(on)} = 6.0 \text{ mA}$	4092 4093		35 60	ns ns
t _{off}	Turn-Off Time	$I_{D(on)} = 3.0 \text{ mA}$ $V_{GS(off)} = 12 \text{ V}$	4093		40	ns
		$V_{GS(off)} = 12 \text{ V}$ $V_{GS(off)} = 6.0 \text{ V}$	4092		60	ns
		$V_{GS(off)} = 3.0 \text{ V}$	4093	I	80	ns

^{*}Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 1.0%

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